

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/833,260	HACKE, HANS-JURGEN	
Examiner	Art Unit	
Nitin Parekh	2811	

						IS	SSU	EC	LAS	SIF	CA	TION	J						
		ORIGIN	AL										REFER	ENCE(S	3)				
CLASS SUBCLASS C						LASS			R BLO	ск)									
25	7		692	2		257	6	90	73	5	736	3	785		697				
NTE	RNATIO	NAL CL	ASSIFIC	CATION															
0	1	L	23/	48															
			23/	52															
			29/	40															
			1																
			1																
	1 I	···•	······································						[\ 		••••• ! ••				~~ ! ^~~~		1	
		1													Total	Clain	ns Allo	wed:	19
	(Assi	stant E	xamine	r) (C)ate)					in Pa									
Ē	N	<u> </u>		ع[م	1. 🗵		Primary Examiner												G.
\mathbb{N}	SI	w	ر م	3/4/	O() (Date			Te	chnolo	жу С	Center	280]]	ار	. riii)i		(3)	Prin	
(L	sgal IN	ou ulliel	ns EXdi	imier)	(Date	-1			mary Exa			9-≾/ (Date	09/05			1			2
∂c	laims	renur	nbere	d in th	ne sam	ne orde	er as r		ited by			ОС		-	□т	.D.		□R	.1.4
																			T
rınaı	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	0 4 1 2 1
	Ю		ш.	Ю			ō			ō		u.	ō		4	ō			
	52																		
23	54 55																		├-
4	56												-						\vdash
5	58																		
6	59												-						_
7 3	61 63																		┢
9	64																		\vdash
0	65																		
<u>1</u>	66 67															<u> </u>			├_
3	68															[\vdash
4	69																		
5	70																		_
6 7	71 105			<u> </u>									<u> </u>						-
8	106					-													
9	107																		
_									\vdash				ļ						
-						-			$\vdash \vdash \vdash$		 								-
																		-	\vdash
_										_									
			1	ļ	tere erek	i l		radicki.	1 [Maddishir	l .	1			I	nasididi.	1	1
				-									 					 	
																			-